Application/Control No. Applicant(s)/Patent Under Reexamination 10/647,798 MEIER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Eugene H Eickholt 2854 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 400/208 US-4,676,678 06-1987 Watanabe, Junji Α Morgavi, Paul 400/188 US-5,558,449 09-1996 В US-5,984,546 11-1999 Kameyama, Yoshikatsu 400/208 C 358/296 US-5,128,763 07-1992 Sakuragi, Kenkichi D 06-1987 Liu et al. 400/208 US-4,673,304 Ε Imaseki, Chiharu 406/120 US-4,848,941 07-1989 F 400/207 03-1988 Tosa, Takashi US-4,733,980 G US-4,350,453 09-1982 Field et al. 400/208 Н Schoenlein, William J. 400/234 09-1982 US-4,350,454 08-1987 Saitou, Masao 400/208 US-4,687,358 J 347/214 US-6,798,434 09-2004 Shibata et al. K 06-1975 Garberi et al. 400/208 US-3,889,795 L 400/208 08-1975 Brignole, Frederick A. US-3,899,065 М FOREIGN PATENT DOCUMENTS Date **Document Number** Classification Country Name Country Code-Number-Kind Code MM-YYYY JP02002120446A 04-2002 Japan Maruyama Ν 0 Ρ Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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